

# CDx4AC74 Dual Positive-Edge-Triggered D-Type Flip-Flops With Clear And Preset

## 1 Features

- AC types feature 1.5V to 5.5V operation and balanced noise immunity at 30% of the supply
- Speed of bipolar F, AS, and S, with significantly reduced power consumption
- Balanced propagation delays
- $\pm 24\text{mA}$  output drive current – fanout to 15 F devices
- SCR-latchup-resistant CMOS process and circuit design

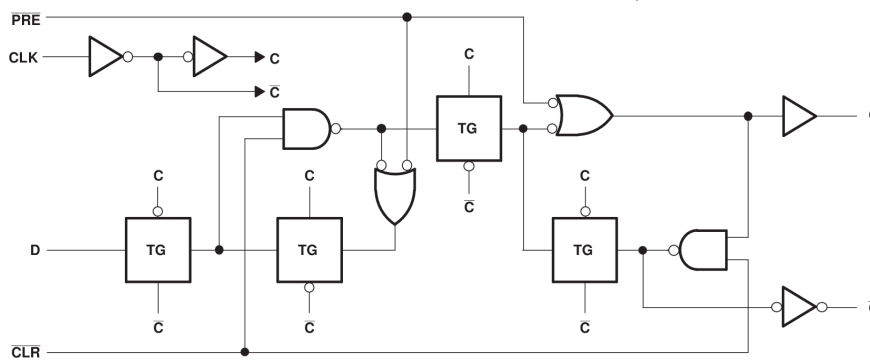
## 2 Description

The 'AC74 dual positive-edge-triggered devices are D-type flip-flops.

### Device Information

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE <sup>(2)</sup>	BODY SIZE <sup>(3)</sup>
CDx4AC74	J (CDIP, 14)	19.56mm × 7.9mm	19.56mm × 6.67mm
	N (PDIP, 14)	19.3mm × 9.4mm	19.3mm × 6.35mm
	D (SOIC, 14)	8.65mm × 6mm	8.65mm × 3.9mm

- (1) For more information, see [Section 10](#).
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.



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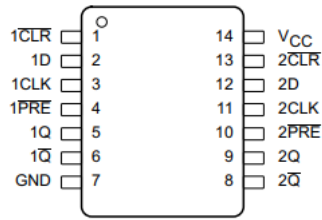
**Logic Diagram, Each Flip-Flop (Positive Logic)**



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### 3 Pin Configuration and Functions



**Figure 3-1. CD54AC74 F Package, 14-Pin CDIP; CD74AC74 E or M Package, 14-Pin PDIP or SOIC (Top View)**

#### Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
1 $\overline{\text{CLR}}$	1	Input	Channel 1, Clear Input, Active Low
1D	2	Input	Channel 1, Data Input
1CLK	3	Input	Channel 1, Positive edge triggered clock input
1 $\overline{\text{PRE}}$	4	Input	Channel 1, Preset Input, Active Low
1Q	5	Output	Channel 1, Output
1 $\overline{\text{Q}}$	6	Output	Channel 1, Inverted Output
GND	7	—	Ground
2 $\overline{\text{Q}}$	8	Output	Channel 2, Inverted Output
2Q	9	Output	Channel 2, Output
2 $\overline{\text{PRE}}$	10	Input	Channel 2, Preset Input, Active Low
2CLK	11	Input	Channel 2, Positive edge triggered clock input
2D	12	Input	Channel 2, Data Input
2 $\overline{\text{CLR}}$	13	Input	Channel 2, Clear Input, Active Low
V <sub>CC</sub>	14	—	Positive Supply

## 4 Specifications

### 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range	-0.5	6	V
I <sub>IK</sub> <sup>1</sup>	Input clamp current	(V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> )		±20 mA
I <sub>OK</sub> <sup>1</sup>	Output clamp current	(V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )		±50 mA
I <sub>O</sub>	Continuous output current	(V <sub>O</sub> = 0 to V <sub>CC</sub> )		±50 mA
	Continuous current through V <sub>CC</sub> or GND			±100 mA
T <sub>stg</sub>	Storage temperature range	-65	150	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 4.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000 V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

### 4.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		T <sub>A</sub> = 25°C		-55°C to 125°C		-40°C to 85°C		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
V <sub>CC</sub>	Supply voltage	1.5	5.5	1.5	5.5	1.5	5.5	V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 1.5 V		1.2		1.2		V
		V <sub>CC</sub> = 3 V		2.1		2.1		
		V <sub>CC</sub> = 5.5 V		3.85		3.85		
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 1.5 V		0.3		0.3		V
		V <sub>CC</sub> = 3 V		0.9		0.9		
		V <sub>CC</sub> = 5.5 V		1.65		1.65		
V <sub>I</sub>	Input voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
V <sub>O</sub>	Output voltage	0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 4.5 V to 5.5 V		-24		-24		mA
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 4.5 V to 5.5 V		24		24		mA
Δt/Δv	Input transition rise or fall rate	V <sub>CC</sub> = 1.5 V to 3 V		50		50		ns/V
		V <sub>CC</sub> = 3.6 V to 5.5 V		20		20		

- (1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

### 4.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		CDx4AC74		UNIT
		N (PDIP)	D (SOIC)	
		14 PINS	14 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	80	119.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 4.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		V <sub>CC</sub>	T <sub>A</sub> = 25°C		-55°C to 125°C		-40°C to 85°C		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
V <sub>OH</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	1.5 V	1.4	1.4	1.4			V	
			3 V	2.9	2.9	2.9				
			4.5 V	4.4	4.4	4.4				
		I <sub>OH</sub> = -4 mA	3 V	2.58	2.4	2.48				
		I <sub>OH</sub> = -24 mA	4.5 V	3.94	3.7	3.8				
		I <sub>OH</sub> = -50 mA <sup>(1)</sup>	5.5 V		3.85					
		I <sub>OH</sub> = -75 mA <sup>(1)</sup>	5.5 V			3.85				
V <sub>OL</sub>	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	1.5 V		0.1	0.1		0.1	V	
			3 V		0.1	0.1		0.1		
			4.5 V		0.1	0.1		0.1		
		I <sub>OL</sub> = 12 mA	3 V		0.36	0.5	0.44			
		I <sub>OL</sub> = 24 mA	4.5 V		0.36	0.5	0.44			
		I <sub>OL</sub> = 50 mA <sup>(1)</sup>	5.5 V			1.65				
		I <sub>OL</sub> = 75 mA <sup>(1)</sup>	5.5 V				1.65			
I <sub>I</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND		5.5 V		±0.1	±1		±1	μA	
I <sub>CC</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND,	I <sub>O</sub> = 0	5.5 V		4	80		40	μA	
C <sub>i</sub>					10	10		10	pF	

- (1) Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.

## 4.6 Timing Requirements, V<sub>CC</sub> = 1.5 V

over recommended operating free-air temperature range, V<sub>CC</sub> = 1.5 V (unless otherwise noted)

			-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency			9		10	MHz
t <sub>w</sub>	Pulse duration	PRE or CLR low		50		44	ns
		CLK		56		49	
t <sub>su</sub>	Setup time	Data		44		39	ns
		PRE or CLR inactive					
t <sub>h</sub>	Hold time	Data after CLK↑		0		0	ns
t <sub>rec</sub>	Recovery time, before CLK↑	CLR↑ or PRE↑		34		30	ns

## 4.7 Timing Requirements, V<sub>CC</sub> = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, V<sub>CC</sub> = 3.3 V ± 0.3 V (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

			-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency			79		90	MHz
t <sub>w</sub>	Pulse duration	PRE or CLR low		5.6		4.9	ns
		CLK		6.3		5.5	

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 over recommended operating free-air temperature range,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$  (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

			-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
$t_{su}$	Setup time	Data	4.9		4.3		ns
		$\overline{PRE}$ or $\overline{CLR}$ inactive					ns
$t_h$	Hold time	Data after CLK↑	0		0		ns
$t_{rec}$	Recovery time, before CLK↑	$\overline{CLR}$ ↑ or $\overline{PRE}$ ↑	4.7		4.1		ns

**4.8 Timing Requirements,  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$** 

 over recommended operating free-air temperature range,  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$  (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

			-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
$f_{clock}$	Clock frequency			110		125	MHz
$t_w$	Pulse duration	$\overline{PRE}$ or $\overline{CLR}$ low	4		3.5		ns
		CLK	4.5		3.9		
$t_{su}$	Setup time	Data	3.5		3.1		ns
		$\overline{PRE}$ or $\overline{CLR}$ inactive					ns
$t_h$	Hold time	Data after CLK↑	0		0		ns
$t_{rec}$	Recovery time, before CLK↑	$\overline{CLR}$ ↑ or $\overline{PRE}$ ↑	2.7		2.4		ns

**4.9 Switching Characteristics,  $V_{CC} = 1.5\text{ V}$** 

 over recommended operating free-air temperature range,  $V_{CC} = 1.5\text{ V}$ ,  $C_L = 50\text{ pF}$  (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
$f_{max}$			9		10		MHz
$t_{PLH}$	CLK	Q or $\overline{Q}$		125		114	ns
$t_{PHL}$				125		114	
$t_{PLH}$	$\overline{PRE}$ or $\overline{CLR}$	Q or $\overline{Q}$		132		120	ns
$t_{PHL}$				144		131	

**4.10 Switching Characteristics,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$** 

 over recommended operating free-air temperature range,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$  (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
$f_{max}$			79		90		MHz
$t_{PLH}$	CLK	Q or $\overline{Q}$	3.5	14	3.6	12.7	ns
$t_{PHL}$			3.5	14	3.6	12.7	
$t_{PLH}$	$\overline{PRE}$ or $\overline{CLR}$	Q or $\overline{Q}$	3.7	14.7	3.8	13.4	ns
$t_{PHL}$			4	16.1	4.1	14.6	

#### 4.11 Switching Characteristics, $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$

over recommended operating free-air temperature range,  $V_{CC} = 5\text{ V} \pm 0.5\text{ V}$  (unless otherwise noted) (see [Load Circuit and Voltage Waveforms](#))

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to 125°C		-40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
$f_{\max}$			110		125		MHz
$t_{\text{PLH}}$	CLK	Q or $\bar{Q}$	2.5	10	2.6	9.1	ns
$t_{\text{PHL}}$			2.5	10	2.6	9.1	
$t_{\text{PLH}}$	$\bar{\text{PRE}}$ or $\bar{\text{CLR}}$	Q or $\bar{Q}$	2.6	10.5	2.7	9.5	ns
$t_{\text{PHL}}$			2.9	11.5	3	10.4	

#### 4.12 Operating Characteristics

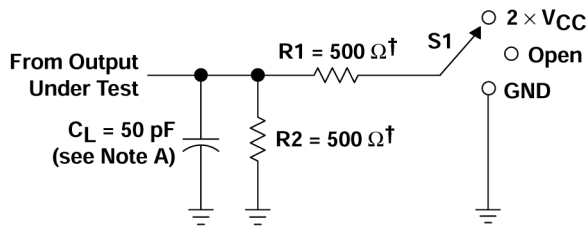
$T_A = 25^\circ\text{C}$

PARAMETER		TYP	UNIT
$C_{\text{pd}}$	Power dissipation capacitance	55	pF

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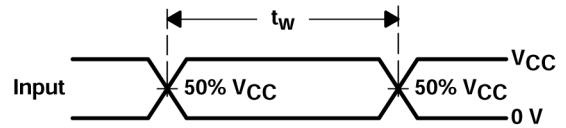
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5 Parameter Measurement Information

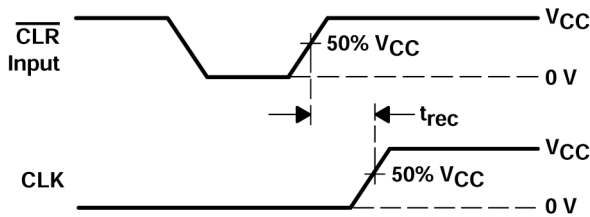


$^\dagger$  When  $V_{CC} = 1.5 \text{ V}$ ,  $R_1 = R_2 = 1 \text{ k}\Omega$

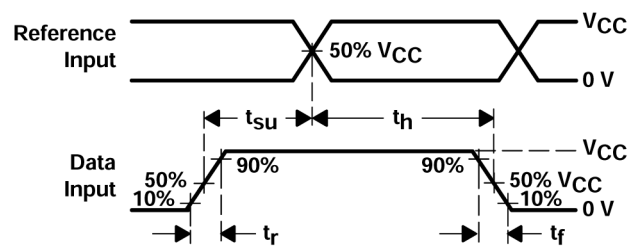
LOAD CIRCUIT



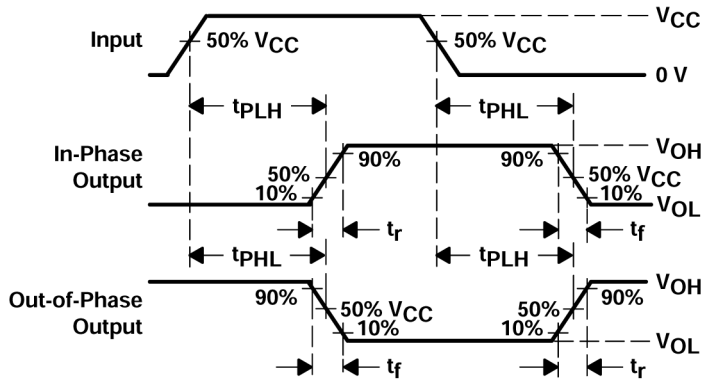
VOLTAGE WAVEFORMS  
PULSE DURATION



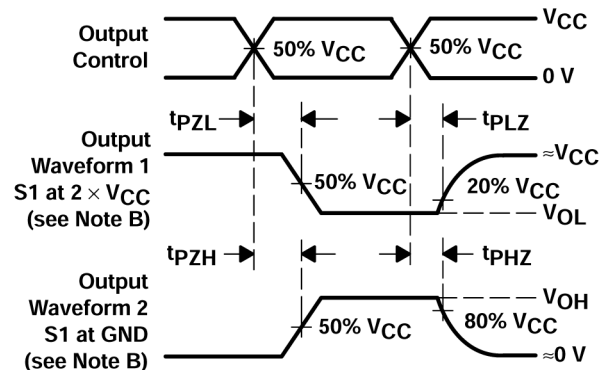
VOLTAGE WAVEFORMS  
RECOVERY TIME



VOLTAGE WAVEFORMS  
SETUP AND HOLD AND INPUT RISE AND FALL TIMES



VOLTAGE WAVEFORMS  
PROPAGATION DELAY AND OUTPUT TRANSITION TIMES



VOLTAGE WAVEFORMS  
OUTPUT ENABLE AND DISABLE TIMES

Figure 5-1. Load Circuit and Voltage Waveforms



- A.  $C_L$  includes probe and test-fixture capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1$  MHz,  $Z_O = 50 \Omega$ ,  $t_r = 3$  ns,  $t_f = 3$  ns. Phase relationships between waveforms are arbitrary.
- D. For clock inputs,  $f_{max}$  is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- G.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- H.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

TEST	S1
$t_{PLH}/t_{PHL}$	Open
$t_{PLZ}/t_{PZL}$	$2 \times V_{CC}$
$t_{PHZ}/t_{PZH}$	GND

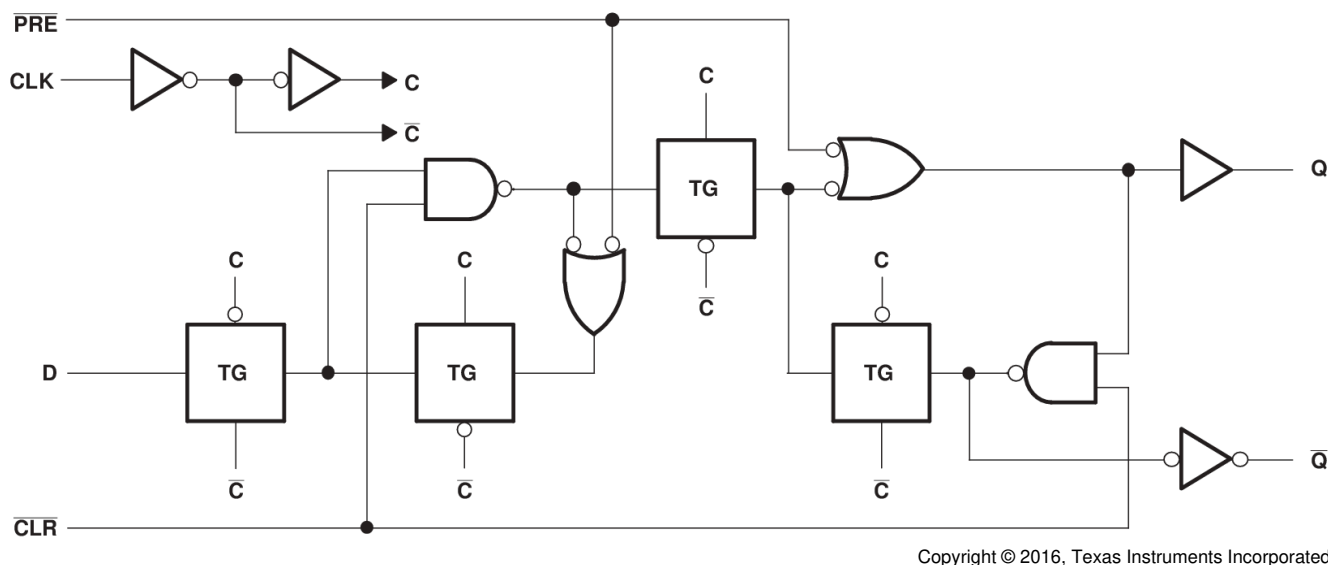
## 6 Detailed Description

### 6.1 Overview

The 'AC74 dual positive-edge-triggered devices are D-type flip-flops.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not related directly to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

### 6.2 Functional Block Diagram



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Figure 6-1.

### 6.3 Device Functional Modes

Table 6-1. Function Table (Each Flip-flop)

INPUTS				OUTPUTS	
PRE	CLR	CLK	D	Q	Q̄
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H <sup>(1)</sup>	H <sup>(1)</sup>
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q <sub>0</sub>	Q̄ <sub>0</sub>

(1) This configuration is nonstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.

## 7 Application and Implementation

### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### Power Supply Recommendations

The power supply may be any voltage between the minimum and maximum supply voltage rating located in [Section 4.3](#).

Each  $V_{CC}$  terminal must have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu\text{F}$  capacitor is recommended for devices with a single supply. If there are multiple  $V_{CC}$  terminals, then 0.01- $\mu\text{F}$  or 0.022- $\mu\text{F}$  capacitors are recommended for each power terminal. It is permissible to parallel multiple bypass capacitors to reject different frequencies of noise. Multiple bypass capacitors may be paralleled to reject different frequencies of noise. The bypass capacitor must be installed as close to the power terminal as possible for the best results.

### 7.1 Layout

#### 7.1.1 Layout Guidelines

Inputs must not float when using multiple bit logic devices. In many cases, functions or parts of functions of digital logic devices are unused. Some examples include situations when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in [Layout Example for the CD74AC74](#) are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, they are tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient.

#### 7.1.2 Layout Example

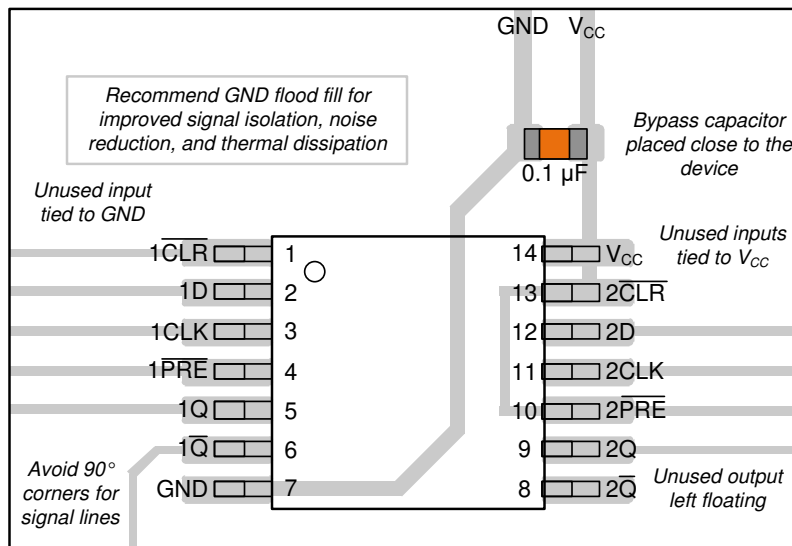


Figure 7-1. Example layout for the CD74AC74

## 8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 8.1 Documentation Support (Analog)

#### 8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
CD54AC74	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>
CD74AC74	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>	<a href="#">Click here</a>

### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.3 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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### 8.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.  
All trademarks are the property of their respective owners.

### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 8.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (December 2002) to Revision E (August 2024)	Page
• Added <i>Device Information</i> table, <i>Pin Functions</i> table, <i>ESD Ratings</i> table, <i>Thermal Information</i> table, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section .....	1
• Updated RθJA values: D = 86 to 119.9, all values in °C/W.....	4

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD54AC74F3A	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD54AC74F3A	<a href="#">Samples</a>
CD74AC74E	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC74E	<a href="#">Samples</a>
CD74AC74M	OBSOLETE	SOIC	D	14		TBD	Call TI	Call TI	-55 to 125	AC74M	
CD74AC74M96	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC74M	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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**OTHER QUALIFIED VERSIONS OF CD54AC74, CD74AC74 :**

- Catalog : [CD74AC74](#)
- Military : [CD54AC74](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC74M96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1



**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC74M96	SOIC	D	14	2500	356.0	356.0	35.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CD74AC74E	N	PDIP	14	25	506	13.97	11230	4.32
CD74AC74E	N	PDIP	14	25	506	13.97	11230	4.32

J 14

**GENERIC PACKAGE VIEW**  
**CDIP - 5.08 mm max height**  
CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4040083-5/G

J0014A



# PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



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NOTES:

1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

# EXAMPLE BOARD LAYOUT

J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



LAND PATTERN EXAMPLE  
NON-SOLDER MASK DEFINED  
SCALE: 5X



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D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

N (R-PDIP-T\*\*)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
  - The 20 pin end lead shoulder width is a vendor option, either half or full width.



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